TOSHIBA Multichip Discrete Device

HN7G06FU

- Power Management Switch Applications, Inverter Circuit Applications, Driver Circuit Applications and Interface Circuit Applications
- Combining transistor and BRT reduces the parts count, enabling the design of more compact equipment with a simpler system configuration.
 - Q1: 2SA1955F equivalent
 - Q2: RN1104F equivalent

Q1 Maximum Ratings (Ta = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-base voltage	V _{CBO}	-15	V
Collector-emitter voltage	V _{CEO}	-12	V
Emitter-base voltage	V _{EBO}	-5	V
Collector current	Ι _C	-500	mA
Base current	Ι _Β	-50	mA

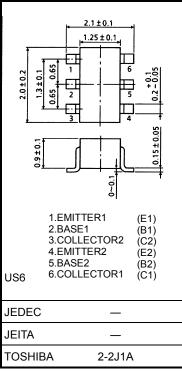
Q2 Maximum Ratings (Ta = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-base voltage	V _{CBO}	50	V
Collector-emitter voltage	V _{CEO}	50	V
Emitter-base voltage	V _{EBO}	10	V
Collector current	Ι _C	100	mA

Q1, Q2 Common Ratings (Ta = 25°C)

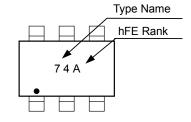
Characteristic	Symbol	Rating	Unit
Collector power dissipation	P _C *	200	mW
Junction temperature	Tj	150	°C
Storage temperature range	T _{stg}	-55~150	°C

*: Total rating. 130 mW per element should not be exceeded.

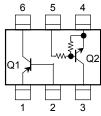


Weight: 0.0068 g (typ.)

Marking



Equivalent Circuit (top view)



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Unit: mm

Q1 Electrical Characteristics (Ta = 25°C)

Characte	ristic	Symbol	Test Condition	Min	Тур.	Max	Unit
Collector cutoff current		I _{CBO}	$V_{CB} = -15 \text{ V}, \text{ I}_{E} = 0$	_		-100	nA
Emitter cutoff current		I _{EBO}	$V_{EB} = -5 \text{ V}, \text{ I}_{C} = 0$	_	_	-100	nA
DC current gain		h _{FE} **	$V_{CE} = -2 V, I_C = -10 mA$	300		1000	
Collector-emitter saturation voltage		V _{CE (sat)(1)}	$I_{C} = -10$ mA, $I_{B} = -0.5$ mA	_	-15	-30	mV
		V _{CE (sat)(2)}	$I_{C} = -200 \text{ mA}, I_{B} = -10 \text{ mA}$	_	-110	-250	
Base-emitter saturation	voltage	V _{BE (sat)}	$I_{C} = -200 \text{ mA}, I_{B} = -10 \text{ mA}$	_	-0.87	-1.2	V
Transition frequency		f _T	$V_{CE} = -2 V, I_C = -10 mA$	_	130	_	MHz
Collector output capacitance		C _{ob}		_	4.2	_	pF
Switching time S	Turn-on time	t _{on}	OUTPUT INPUT 300Ω 0 V $10 \mu s$ W W W W W W W W		40	_	ns
	Storage time	t _{stg}		_	280	_	ns
	Fall time	t _f			6		ns

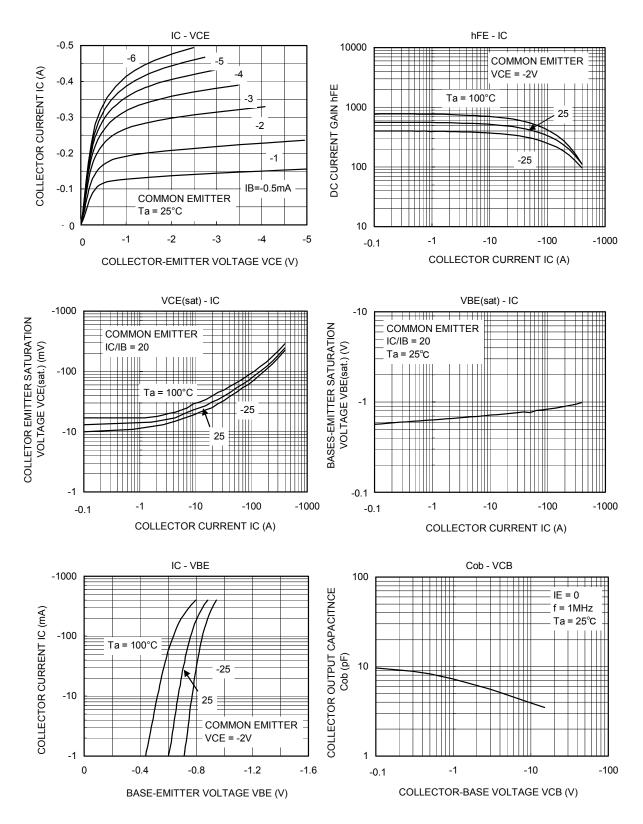
**: h_{FE} Classification A:300~600, B:500~1000

Q2 Electrical Characteristics (Ta = 25°C)

Characteristic	Symbol	Test Condition	Min	Тур.	Max	Unit
Collector cutoff current	I _{CBO}	$V_{CB}=50\ V,\ I_{E}=0$	_		100	nA
	I _{CEO}	$V_{CE}=50~V,~I_{E}=0$	_	_	500	nA
Emitter cutoff current	I _{EBO}	$V_{EB} = 10 V, I_{C} = 0$	0.082	_	0.15	mA
DC current gain	h _{FE}	$V_{CE}=5~V,~I_C=10~mA$	80	_		
Collector-emitter saturation voltage	V _{CE (sat)}	$I_{C} = 5 \text{ mA}, I_{B} = 0.25 \text{ mA}$	_	0.1	0.3	V
Input voltage (ON)	V _{I(ON)}	$V_{CE} = 0.2 \text{ V}, \ I_{C} = 5 \text{ mA}$	1.5	_	5.0	V
Input voltage (OFF)	V _{I(OFF)}	$V_{CE} = 5 \text{ V}, I_{C} = 0.1 \text{ mA}$	1.0	_	1.5	V
Transition frequency	f _T	$V_{CE}=10~V,~I_C=5~mA$	_	250	-	MHz
Collector output capacitance	C _{ob}	$V_{CB} = 10 \text{ V}, \text{ I}_{E} = 0, \text{ f} = 1 \text{ MHz}$	_	3	_	pF
Input resistor	R1	—	32.9	47	61.1	kΩ
Resistor ratio	R1/R2	—	0.9	1.0	1.1	

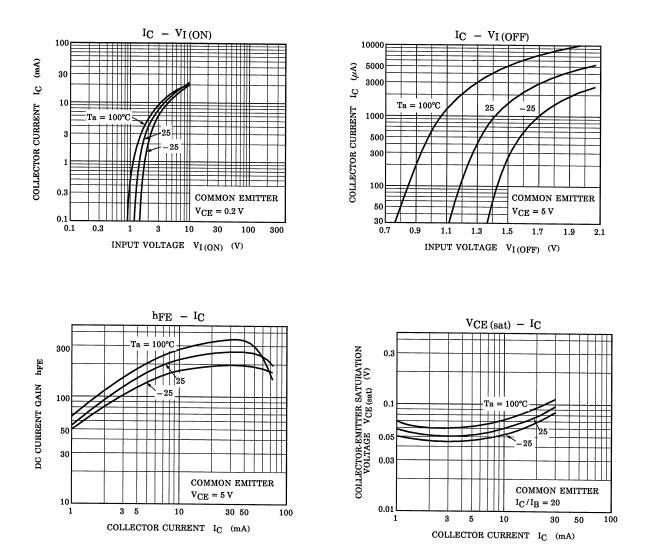
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Q1



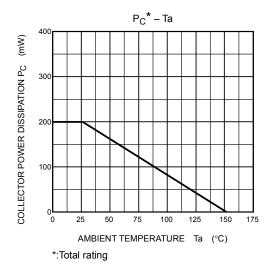
TOSHIBA

Q2



TOSHIBA

Q1, Q2 common



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